

Notice of References Cited	Application/Control No. 09/976,491	Applicant(s)/Patent Under Reexamination DORSEY, MICHAEL C.	
	Examiner John P Trimmings	Art Unit 2133	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,681,359	01-2004	Au et al.	714/733
	B	US-6,665,828	12-2003	Arimilli et al.	714/726
	C	US-6,671,838	12-2003	Koprowski et al.	714/726
	D	US-5,982,189	11-1999	Motika et al.	324/763
	E	US-6,560,740	05-2003	Zuraski et al.	714/733
	F	US-5,661,732	08-1997	Lo et al.	714/725
	G	US-6,636,997	10-2003	Wong et al.	714/728
	H	US-6,587,979	07-2003	Kraus et al.	714/720
	I	US-6,148,426	11-2000	Kim et al.	714/733
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Reducing Test Data Volume using External/LBIST Hybrid Test Patterns", Das et al., ITC Test Conference 2000, October 3-5, 2000, pp 115-122.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

T